

**Search Notes**

Application/Control No.

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Examiner

A. Sefer

Applicant(s)/Patent under  
Reexamination

DESAI ET AL

Art Unit

2826

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	706	6/30/2006	AS
257	707	6/30/2006	AS
438	125	6/30/2006	AS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
search updated	6/30/2006	AS
257/703 257/706 257/717 257/E23.10 6 361/707 361/709 (texh seach)	6/30/2006	AS